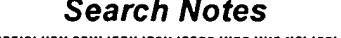


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/777,332	SEITZ ET AL.
	Examiner	Art Unit
	Andy Huynh	2818

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner